



DMP2004TK

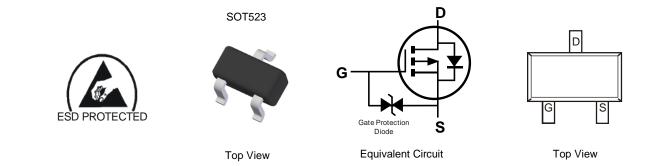
#### P-CHANNEL ENHANCEMENT MODE MOSFET

#### Features

- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- ESD Protected Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

### **Mechanical Data**

- Case: SOT523
- Case Material: Molded Plastic, "Green" Molding Compound.
  UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin Annealed over Alloy 42 leadframe. Solderable per MIL-STD-202, Method 208 (3)
- Terminal Connections: See Diagram
- Weight: 0.002 grams (Approximate)



### Ordering Information (Note 4)

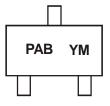
	Part Number	Case	Packaging				
DMP2004TK-7		SOT523	3,000/Tape & Reel				
Notes:	tes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS). 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.						

No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
 See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.</p>

4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

# **Marking Information**



PAB = Product Type Marking Code YM = Date Code Marking Y = Year (ex: F = 2018) M = Month (ex: 9 = September)

Date Code Key

Year	2006	2007		2014	2015	2016	2017	2018	2019	2020	2021	2022
Code	Т	U		В	С	D	E	F	G	Н		J
				-		-		_	-			
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec



# Maximum Ratings (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Chara	acteristic		Symbol	Value	Unit
Drain-Source Voltage			V <sub>DSS</sub>	-20	V
Gate-Source Voltage			V <sub>GSS</sub>	±8	V
Drain Current (Note 5)	Steady State	T <sub>A</sub> = +25°C T <sub>A</sub> = +85°C	١D	-430 -310	mA
Pulsed Drain Current (Note 6)	·		I <sub>DM</sub>	-750	mA

### Thermal Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit	
Total Power Dissipation (Note 5)		PD	230	mW
Thermal Resistance, Junction to Ambient (Note 5)	R <sub>0JA</sub>	558	°C/W	
Total Power Dissipation (Note 6)		PD	320	mW
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	R <sub>0JA</sub>	393	°C/W
Operating and Storage Temperature Range		TJ, TSTG	-55 to +150	°C

# Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

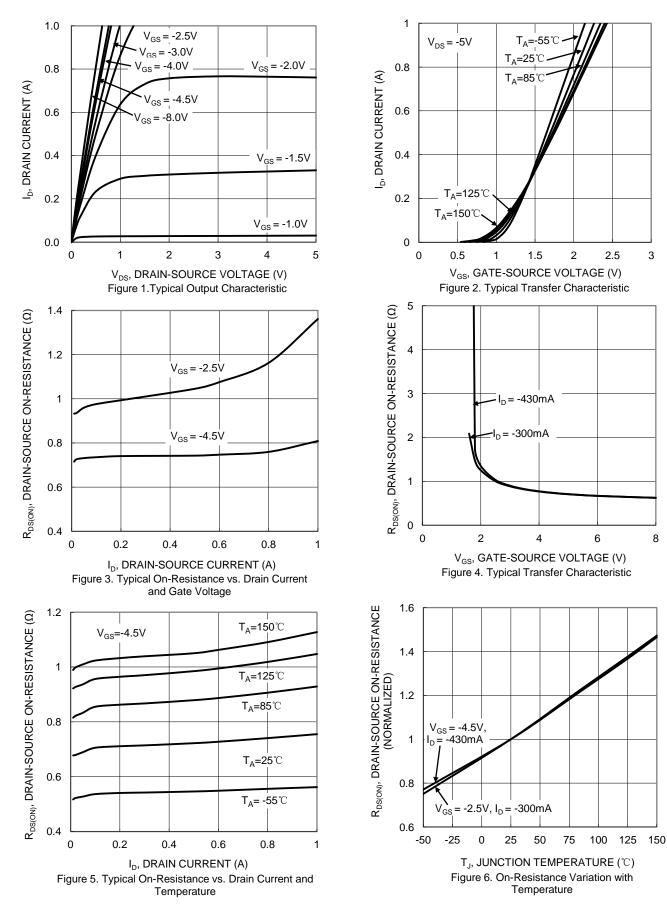
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-20	_		V	$V_{GS} = 0V, I_D = -250 \mu A$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	-1.0	μΑ	$V_{DS} = -20V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>		_	±1.0	μA	$V_{GS} = \pm 4.5 V, V_{DS} = 0 V$	
ON CHARACTERISTICS (Note 7)				•			
Gate Threshold Voltage	V <sub>GS(TH)</sub>	-0.5		-1.0	V	$V_{DS} = V_{GS}$ , $I_D = -250 \mu A$	
			0.7	1.1		$V_{GS} = -4.5V, I_D = -430mA$	
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	_	1.0	1.6	Ω	$V_{GS} = -2.5V, I_D = -300mA$	
			1.3	2.4		V <sub>GS</sub> = -1.8V, I <sub>D</sub> = -150mA	
Diode Forward Voltage	V <sub>SD</sub>	_	-0.8	-1.4	V	$V_{GS} = 0V, I_{S} = -115mA$	
DYNAMIC CHARACTERISTICS (Note 8)				•	•	-	
Input Capacitance	Ciss	_	47		pF		
Output Capacitance	Coss	_	6.8		pF	─ V <sub>DS</sub> = -16V, V <sub>GS</sub> = 0V ─ f = 1.0MHz	
Reverse Transfer Capacitance	Crss	_	4.9	_	pF	1 = 1.0MHZ	
Gate Resistance	Rg	_	240		Ω	$V_{DS} = 0V, V_{GS} = 0V$	
Total Gate Charge V <sub>GS</sub> = -4.5V	Qg	_	0.55	_	nC		
Total Gate Charge V <sub>GS</sub> = -8V	Qg	_	0.97		nC	V <sub>DS</sub> = -10V, I <sub>D</sub> = -250mA	
Gate-Source Charge	Q <sub>gs</sub>		0.05		nC		
Gate-Drain Charge	Q <sub>qd</sub>		0.1		nC		
Turn-On Delay Time	t <sub>D(ON)</sub>		5.9		ns		
Turn-On Rise Time	t <sub>R</sub>	_	3.3	—	ns	$V_{DD} = -3V, V_{GS} = -2.5V,$	
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	25.5	—	ns	$R_{G} = 25\Omega, I_{D} = -100 \text{mA}$	
Turn-Off Fall Time	t <sub>F</sub>	_	19.3	—	ns	7	
Reverse Recovery Time	t <sub>RR</sub>		7.3		ns	I <sub>F</sub> =-1A, di/dt=-100A/µs	
Reverse Recovery Charge	Q <sub>RR</sub>		1.9		nC	I <sub>F</sub> =-1A, di/dt=-100A/µs	

Notes: 5. Device mounted on FR-4 PCB, with minimum recommended pad layout.

Device mounted on 1" x 1" FR-4 PCB with high coverage 2oz. Copper, single sided.
 Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to product testing.

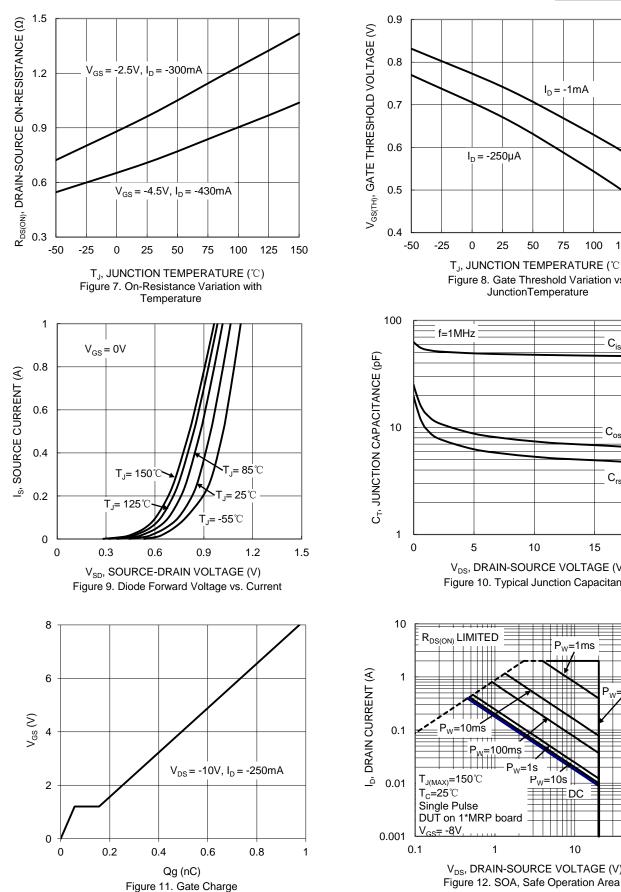


# DMP2004TK









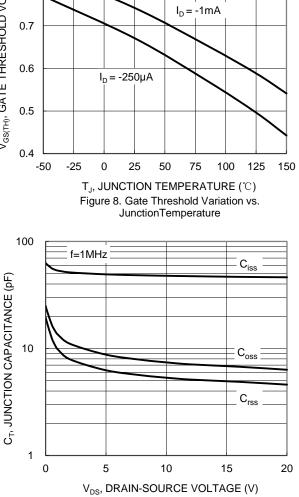
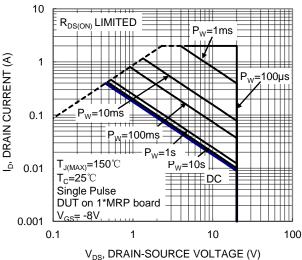
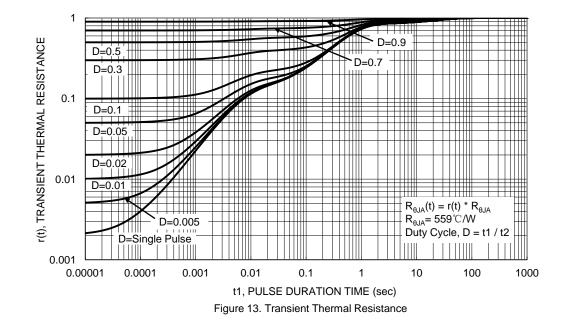


Figure 10. Typical Junction Capacitance

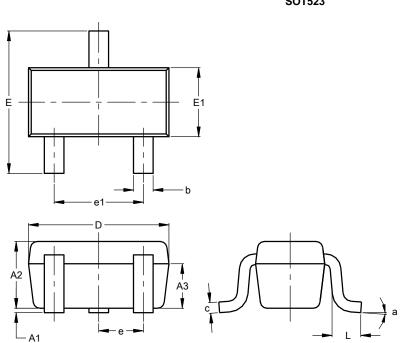






# **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.



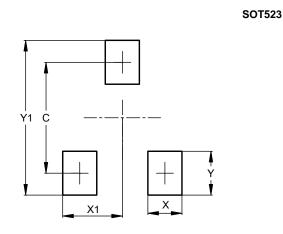
**SOT523** 

SOT523							
Dim	Dim Min Max Typ						
A1	0.00	0.10	0.05				
A2	0.60	0.80	0.75				
A3	0.45	0.65	0.50				
b	0.15	0.30	0.22				
С	0.10	0.20	0.12				
D	1.50	1.70	1.60				
Е	1.45	1.75	1.60				
E1	0.75	0.85	0.80				
e		0.50 BS	iC				
e1	0.90 1.10 1.00						
L	L 0.20		0.33				
а	0°		8°				
All Dimensions in mm							



#### Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.



Dimensions	Value (in mm)
С	1.29
Х	0.40
X1	0.70
Y	0.51
Y1	1.80

#### IMPORTANT NOTICE

DIODES INCORPORATED MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. Diodes Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does Diodes Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on Diodes Incorporated website, harmless against all damages.

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel. Should Customers purchase or use Diodes Incorporated products for any unintended or unauthorized application, Customers shall indemnify and hold Diodes Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

Products described herein may be covered by one or more United States, international or foreign patents pending. Product names and markings noted herein may also be covered by one or more United States, international or foreign trademarks.

This document is written in English but may be translated into multiple languages for reference. Only the English version of this document is the final and determinative format released by Diodes Incorporated.

#### LIFE SUPPORT

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

A. Life support devices or systems are devices or systems which:

- 1. are intended to implant into the body, or
- 2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
- B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

Copyright © 2018, Diodes Incorporated

www.diodes.com



单击下面可查看定价,库存,交付和生命周期等信息

>>Diodes Incorporated(达尔科技)